

P-Channel 150 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)			
- 150	0.185 at V _{GS} = - 10 V	- 30	37 nC			

FEATURES

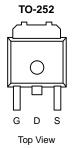
- DT-Trench Power MOSFET
- 100 % R_g and UIS Tested
- Compliant to RoHS Directive 2002/95/EC

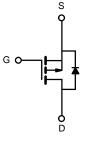


RoHS COMPLIANT

APPLICATIONS

- Active Clamp in Intermediate DC/DC Power Supplies
- H-Bridge High Side Switch for Lighting Application





P-Channel MOSFET

Parameter			Limit	Unit	
Drain-Source Voltage			- 150	V	
Gate-Source Voltage			± 20	V	
	T _C = 25 °C		- 30		
Continuous Prais Current /T 150 °C)	T _C = 70 °C	1 , [- 26.3		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	- I _D	- 3.4 ^{a, b}		
	T _A = 70 °C	1	- 2.5 ^{a, b}	_	
Pulsed Drain Current			- 120	A	
Castinuana Cannas Dasia Diada Consest	T _C = 25 °C		- 30		
Continuous Source-Drain Diode Current	T _A = 25 °C	ls l	- 4.3 ^{a, b}		
Avalanche Current	L = 0.1 mH	I _{AS}	29		
Single-Pulse Avalanche Energy	L = 0.1 IIII	E _{AS}	103	mJ	
	T _C = 25 °C		108		
Maximum Dawar Dissination	T _C = 70 °C		99	W	
Maximum Power Dissipation	T _A = 25 °C	- P _D	5.9 ^{a, b}		
	T _A = 70 °C		4.8 ^{a, b}		
Operating Junction and Storage Temperature Range			- 50 to 150	°C	
Soldering Recommendations (Peak Temperature)		260	1 -0		

Notes:

Rev. 1.0 1

a. Surface mounted on 1" x 1" FR4 board.

b. t = 10 s.



THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, b}	t ≤ 10 s	R _{thJA}	35	60	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	0.6	1.5	C/VV	

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. Maximum under steady state conditions is 81 °C/W.

Parameter	Symbol	Test Conditions		Тур.	Max.	Unit	
Static				•		,	
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V, } I_D = -250 \mu\text{A}$	- 150			V	
V _{DS} Temperature Coefficient	AVpe/Ti			- 168		m) 1/91	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		- 6.6		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 2		- 4	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	lana	V _{DS} = - 150 V, V _{GS} = 0 V			- 1		
Zero Gate voltage Drain Current	IDSS	$V_{DS} = -120 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			- 10	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 30			Α	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 10 V, I _D = - 5 A		0.185	0.225	Ω	
Forward Transconductance ^a	9 _{fs}	$V_{DS} = -5 \text{ V}, I_{D} = -5 \text{ A}$		15		S	
Dynamic ^b							
Input Capacitance	C _{iss}			1208		pF	
Output Capacitance	C _{oss}	$V_{DS} = -75 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		155			
Reverse Transfer Capacitance	C _{rss}			66			
Total Gate Charge	Q_g			37		nC	
Gate-Source Charge	Q_{gs}	$V_{DS} = -75 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -5 \text{ A}$		10			
Gate-Drain Charge	Q_{gd}			18			
Gate Resistance	R_g	f = 1 MHz		6		Ω	
Turn-On Delay Time	t _{d(on)}			22			
Rise Time	t _r	$V_{DD} = -75 \text{ V}, R_L = 25 \Omega$		45			
Turn-Off DelayTime	$t_{d(off)}$	$I_D \cong -5 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		53		ns	
Fall Time	t _f			28		<u> </u>	
Drain-Source Body Diode Characterist	cs						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 30	Α	
Pulse Diode Forward Current ^a	I _{SM}				- 120	_ ^	
Body Diode Voltage	V_{SD}	I _S = - 5 A		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			92		ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 20 A, dI/dt = 100 A/μs, T _J = 25 °C		118		nC	
Reverse Recovery Fall Time	t _a			37		no	
Reverse Recovery Rise Time	t _b			31		ns	

Notes:

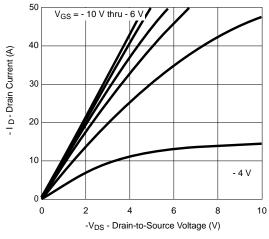
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

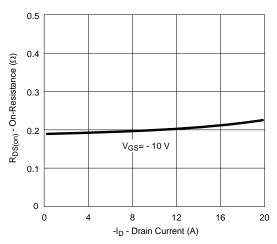
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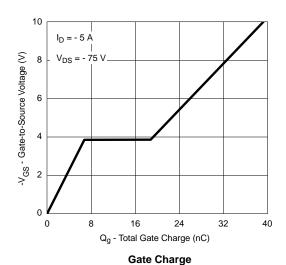
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)







On-Resistance vs. Drain Current and Gate Voltage



2.0 (4) 1.6 T_C = 125 °C

T_C = 125 °C

0.4

25 °C

-55 °C

2

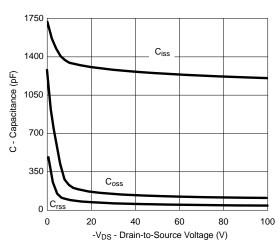
0

-V_{GS} - Gate-to-Source Voltage (V)

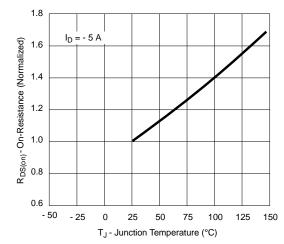
Transfer Characteristics

3

4



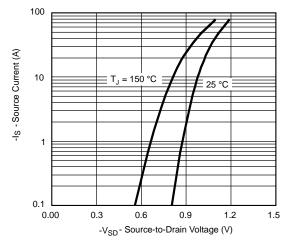
Capacitance



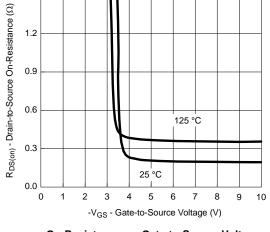
On-Resistance vs. Junction Temperature



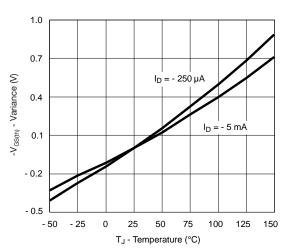
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



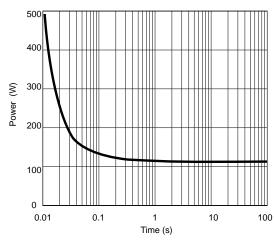
Source-Drain Diode Forward Voltage



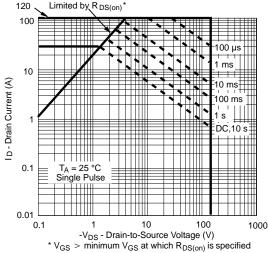
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



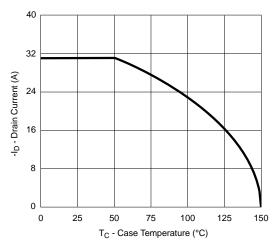
Single Pulse Power, Junction-to-Case



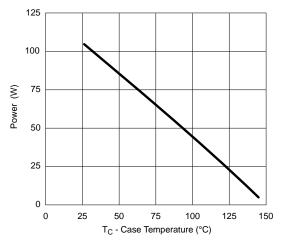
Safe Operating Area, Junction-to-Ambient

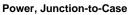


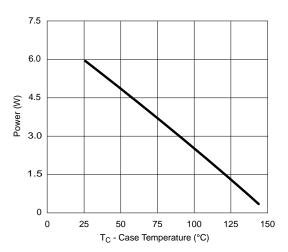
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*







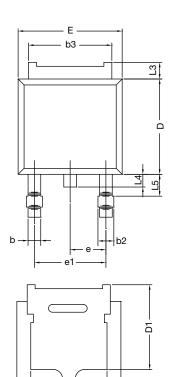
Power, Junction-to-Ambient

^{*} The power dissipation PD is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

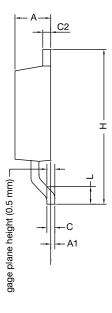


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TO-252AA CASE OUTLINE



E1



	MILLIMETERS		INC	HES		
DIM.	MIN.	MAX.	MIN.	MAX.		
А	2.18	2.38	0.086	0.094		
A1	-	0.127	-	0.005		
b	0.64	0.88	0.025	0.035		
b2	0.76	1.14	0.030	0.045		
b3	4.95	5.46	0.195	0.215		
С	0.46	0.61	0.018	0.024		
C2	0.46	0.89	0.018	0.035		
D	5.97	6.22	0.235	0.245		
D1	5.21	-	0.205	-		
Е	6.35	6.73	0.250	0.265		
E1	4.32	-	0.170	-		
Н	9.40	10.41	0.370	0.410		
е	2.28	B BSC 0.090 BS		90 BSC		
e1	4.56	4.56 BSC		0.180 BSC		
L	1.40	1.78	0.055	0.070		
L3	0.89	1.27	0.035	0.050		
L4	-	1.02	-	0.040		
L5	1.14	1.52	0.045	0.060		
ECN: X12-0247-Rev. M, 24-Dec-12						

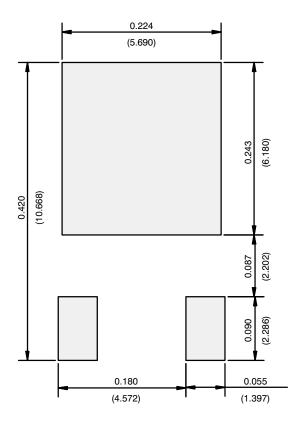
DWG: 5347

Note

• Dimension L3 is for reference only.

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RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)





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